

Product Summary

$V_{(BR)DSS}$	$R_{DS(on)TYP}$	I_D
-60V	8mΩ@-10V	-75A
	10mΩ@-4.5V	



合肥矽普半导体

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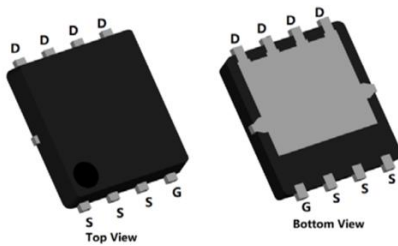
Feature

- Fast switching speed
- Surface mount package
- ROHS Compliant & Halogen-Free
- Advanced Split Gate Trench Technology
- 100% Single Pulse avalanche energy Test

Applications

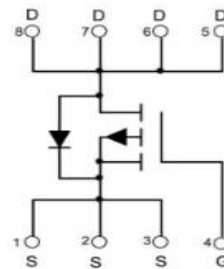
- DC-DC Converters.
- Motor Control.

Package

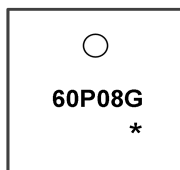


PDFN5×6-8L

Circuit diagram



Marking



60P08G :Device Code
* :Month Code

Order Information

Device	Package	Unit/Tape
SP60P08GNK	PDFN5×6-8L	5000

Absolute maximum ratings (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V _{DSS}	-60	V
Gate-Source Voltage	V _{GSS}	±20	V
Continuous Drain Current(Tc=25°C)	I _D	-75	A
Continuous Drain Current(Tc=100°C)	I _D	-50	A
Pulse Drain Current Tested	I _{DM}	-300	A
Maximum Power Dissipation(Tc=25°C)	P _D	110	W
Single pulsed avalanche energy ¹	EAS	453	mJ
Thermal Resistance-Junction to Case	R _{θJC}	1.13	°C/W
Maximum Junction Temperature	T _J	-55 to 150	°C
Storage Temperature Range	T _{STG}	-55 to 150	°C

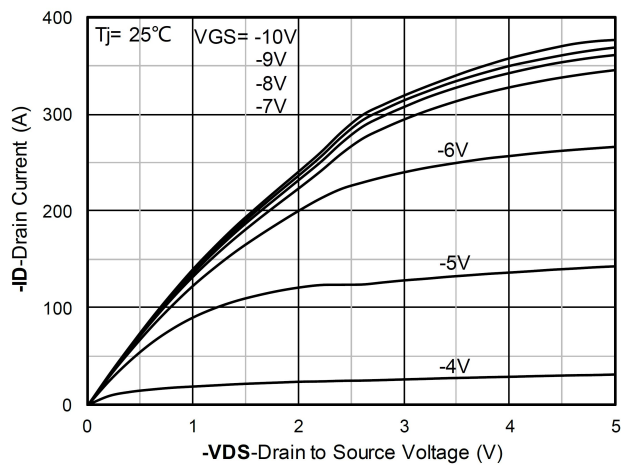
Electrical characteristics (Ta=25°C, unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Static Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	VGS=0V , ID=-250uA	-60	-	-	V
Drain-Source Leakage Current	I _{DSS}	VDS=-48V , VGS=0V , TJ=25℃	-	-	-1	uA
Gate-Source Leakage Current	I _{GSS}	VGS=±20V , VDS=0V	-	-	±100	nA
Gate Threshold Voltage	V _{GS(th)}	VGS=VDS , ID =-250uA	-1.0	-1.8	-2.5	V
Static Drain-Source On-Resistance	R _{DS(ON)}	VGS=-10V , ID=-15A	-	8	10	mΩ
		VGS=-4.5V , ID=-15A	-	10	13.5	mΩ
Dynamic characteristics						
Input Capacitance	C _{iss}	VDS=-30V , VGS=0V , f=1MHz	-	4483	-	pF
Output Capacitance	C _{OSS}		-	865	-	
Reverse Transfer Capacitance	C _{rss}		-	22	-	
Switching Characteristics						
Total Gate Charge	Q _g	VDS=-30V , VGS=-10V , ID=-15A	-	52	-	nC
Gate-Source Charge	Q _{gs}		-	9	-	
Gate-Drain Charge	Q _{gd}		-	8	-	
Turn-On Delay Time	T _{d(on)}	VDD=-30V, VGS=-10V , RG=3Ω, ID=-15A	-	18	-	ns
Rise Time	T _r		-	20	-	
Turn-Off Delay Time	T _{d(off)}		-	54	-	
Fall Time	T _f		-	34	-	
Diode Characteristics						
Diode Forward Voltage	V _{SD}	VGS=0V , IS=-1A , TJ=25℃	-	-	-1.2	V
Reverse recover time	T _{rr}	I _S =-15A, di/dt=100A/us, TJ=25℃	-	49	-	ns
Reverse recovery charge	Q _{rr}		-	70	-	nC
Diode Continuous Current	I _S		-	-	-75	A

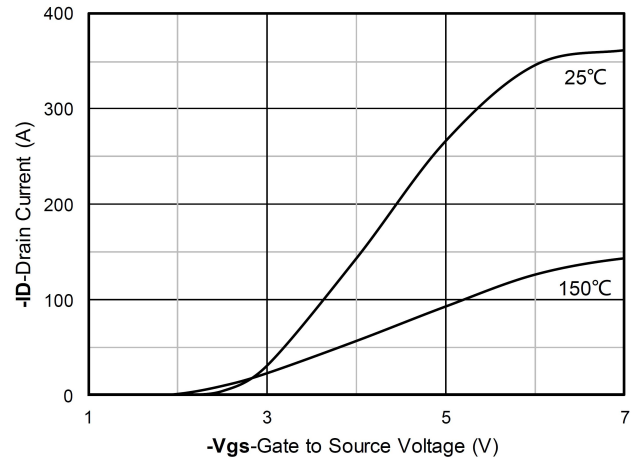
Note:

1. EAS is tested at starting TJ = 25°C, VDD=-30V, VGS = -10V, L = 0.5mH, Rg=25mΩ;

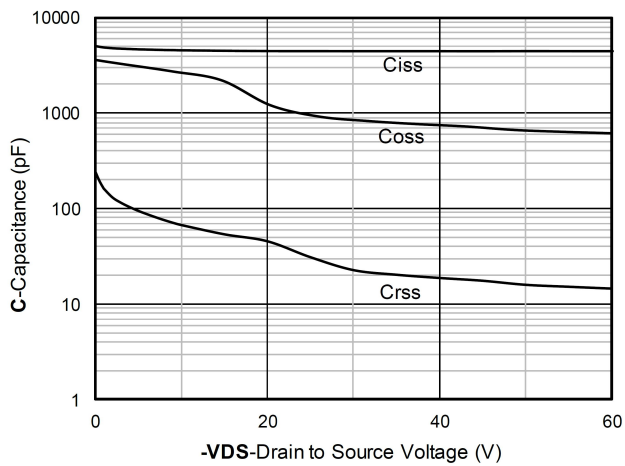
Typical Characteristics



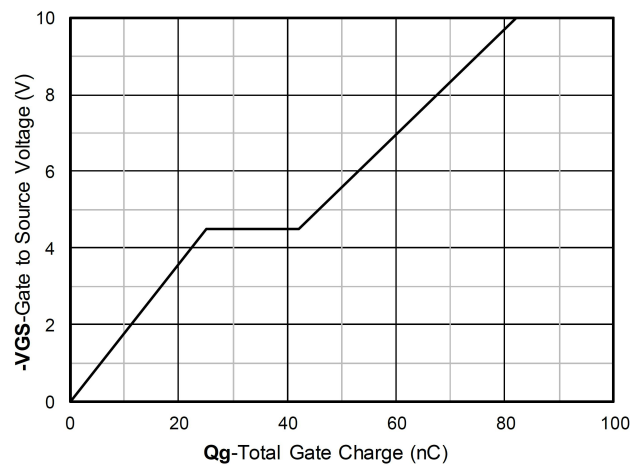
Output Characteristics



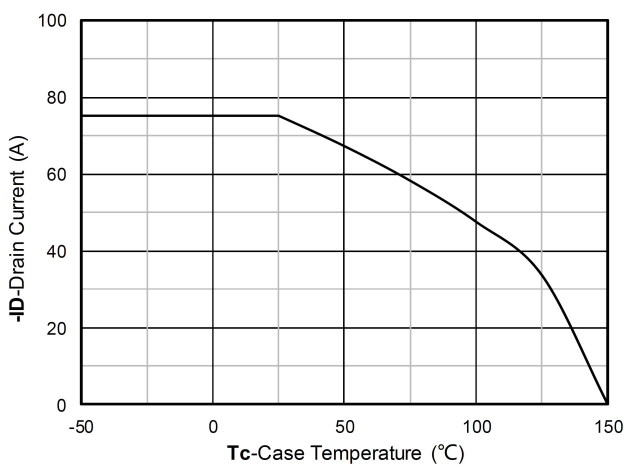
Transfer Characteristics



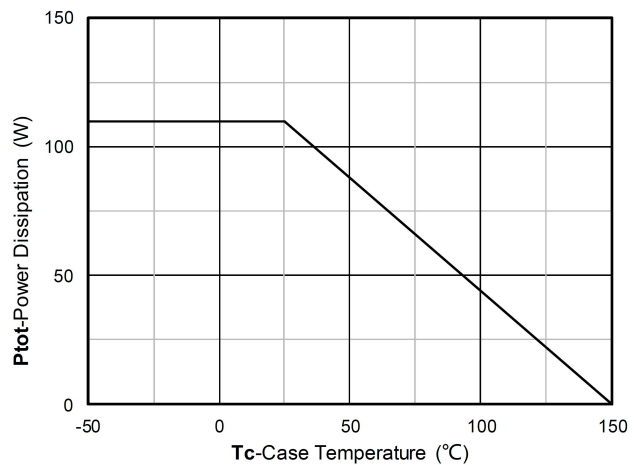
Capacitance Characteristics



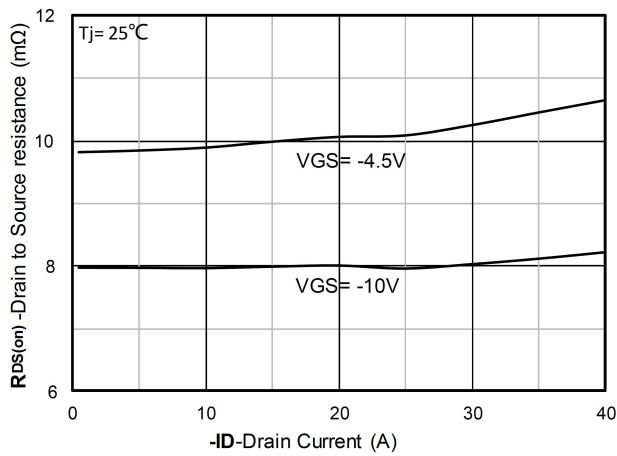
Gate Charge



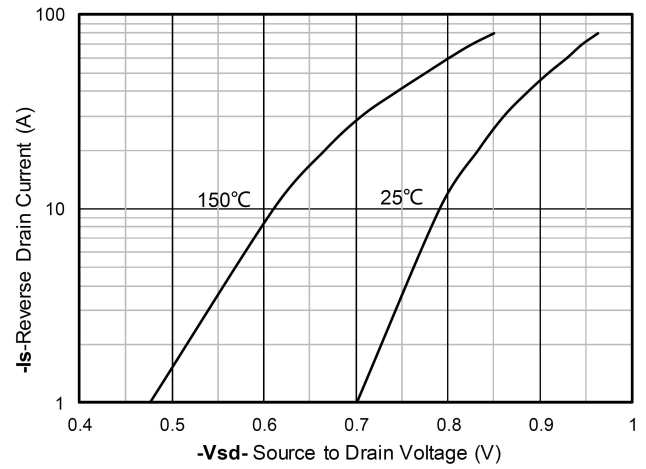
Current dissipation



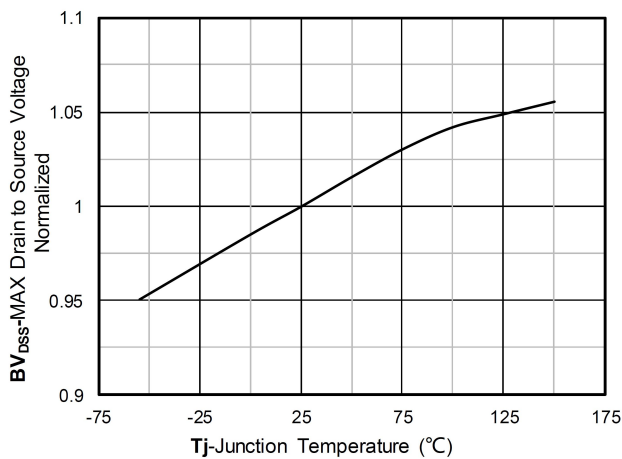
Power dissipation



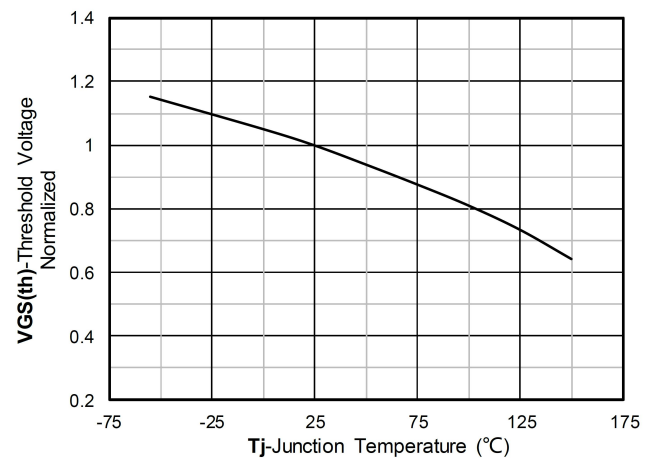
$R_{DS(on)}$ VS Drain Current



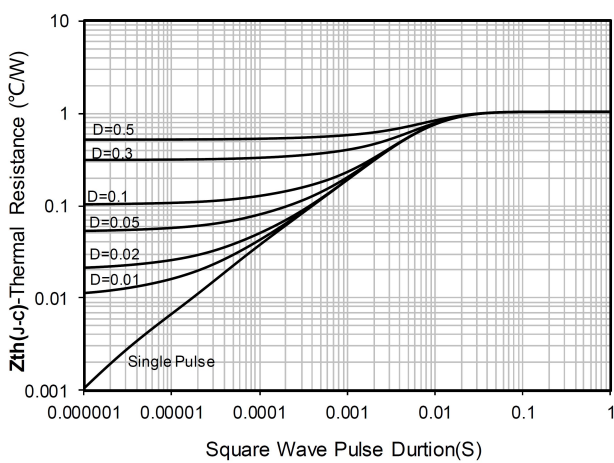
Forward characteristics of reverse diode



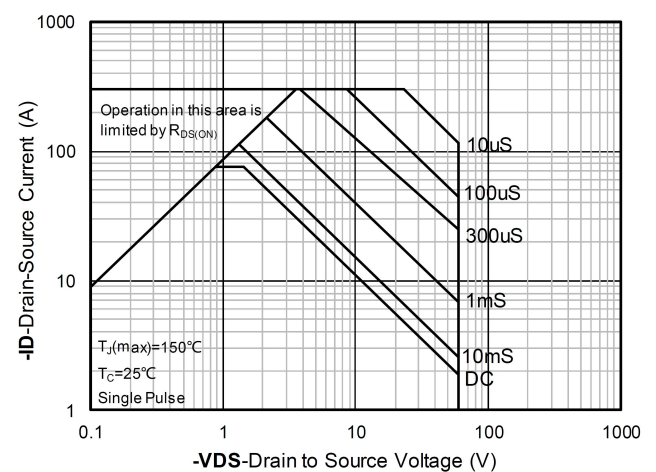
Normalized breakdown voltage



Normalized Threshold voltage



Maximum Transient Thermal Impedance



Safe Operation Area

